

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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Self-Protected Low Side Driver with Temperature and Current Limit

NCV8401A/B is a three terminal protected Low-Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain-to-Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

Features

- Short Circuit Protection
- Thermal Shutdown with Automatic Restart
- Over Voltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

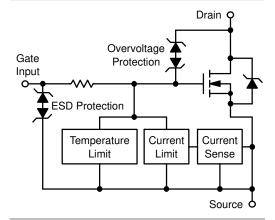


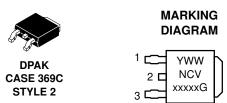
ON Semiconductor®

www.onsemi.com

V _{DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX (Limited)
42 V	23 mΩ @ 10 V	33 A*

*Max current may be limited below this value depending on input conditions.





Y = Year

1

WW = Work Week 1 = Gate xxxxx = 8401A or 8401B 2 = Drain G = Pb-Free Package 3 = Source

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8401ADTRKG	DPAK (Pb-Free)	2500/Tape & Reel
NCV8401BDTRKG	DPAK (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

	Rating		Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped			V _{DSS}	42	V
Drain-to-Gate Voltage Internally	y Clamped	$(R_{GS} = 1.0 M\Omega)$	V_{DGR}	42	V
Gate-to-Source Voltage			V _{GS}	±14	V
Orain Current – Continuous			I _D	Internally Limited	
Total Power Dissipation @ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2)			P _D	1.1 2.0	W
J	unction-to-Case unction-to-Ambient (Note 1) unction-to-Ambient (Note 2)		$egin{aligned} R_{ hetaJC} \ R_{ hetaJA} \end{aligned}$	1.6 110 60	°C/W
Single Pulse Drain–to–Source Avalanche Energy (V_{DD} = 25 Vdc, V_{GS} = 5.0 Vdc, I_L = 3.65 Apk, L = 120 mH, R_G = 25 Ω , T_{Jstart} = 150°C) (Note 3)			E _{AS}	800	mJ
Load Dump Voltage (V_{GS} = 0 and 10 V, R_I = 2.0 Ω , R_L = 3.0 Ω , t_d = 400 ms)			V_{LD}	65	V
Operating Junction Temperature			TJ	-40 to 150	°C
Storage Temperature			T _{stg}	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Minimum FR4 PCB, steady state.

2. Mounted onto a 2" square FR4 board

(1" square, 2 oz. Cu 0.06" FR4 board

(1" square, 2 oz. Cu 0.06" to thick single—sided, t = steady state).

- 3. Not subject to production testing.

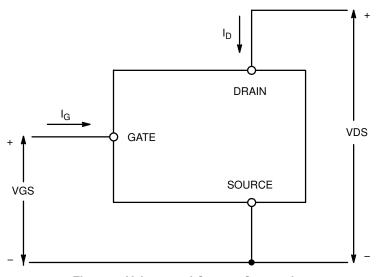


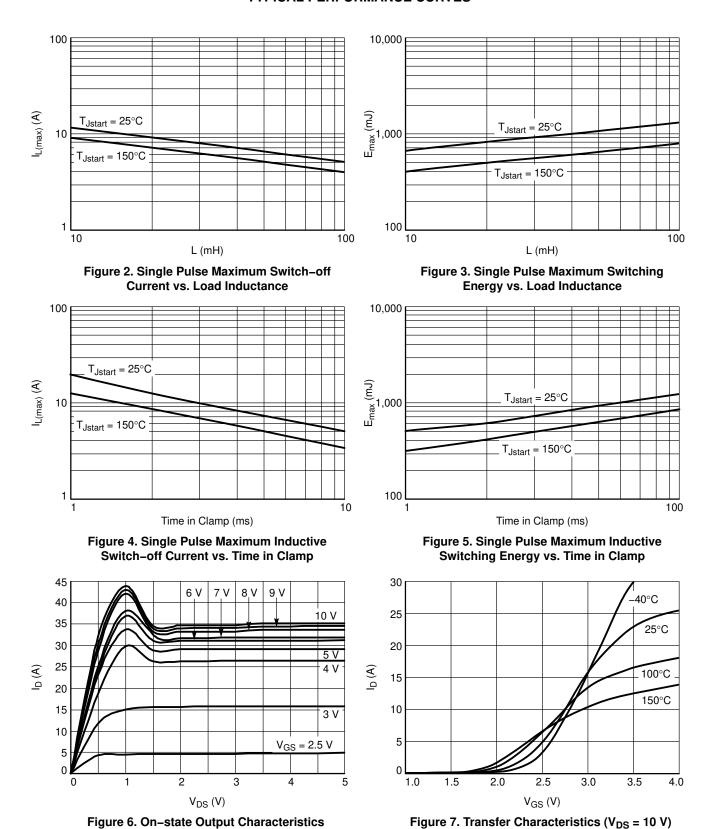
Figure 1. Voltage and Current Convention

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Characte	ristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Clamped Breakdown Vo (V _{GS} = 0 Vdc, I _D = 250 μ Adc) (V _{GS} = 0 Vdc, I _D = 250 μ Adc, T,	· ·	V _{(BR)DSS}	42 42	46 44	50 50	Vdc
Zero Gate Voltage Drain Current $(V_{DS} = 32 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 32 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J})$	= 150°C) (Note 4)	I _{DSS}		1.5 6.5	5.0	μAdc
Gate Input Current ($V_{GS} = 5.0 \text{ Vdc}, V_{DS} = 0 \text{ Vdc}$)	I _{GSSF}		50	100	μAdc	
ON CHARACTERISTICS						
Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 1.2 mAdc) Threshold Temperature Coefficient		V _{GS(th)}	1.0	1.8 5.0	2.0	Vdc -mV/°C
Static Drain-to-Source On-Resistance (N $_{GS}$ = 10 Vdc, I $_{D}$ = 5.0 Adc, T $_{J}$ (V $_{GS}$ = 10 Vdc, I $_{D}$ = 5.0 Adc, T $_{J}$	@ 25°C)	R _{DS(on)}		23 43	29 55	mΩ
$ \begin{array}{l} \text{Static Drain-to-Source On-Resistance (N} \\ \text{(V}_{GS} = 5.0 \text{ Vdc, I}_{D} = 5.0 \text{ Adc, T} \\ \text{(V}_{GS} = 5.0 \text{ Vdc, I}_{D} = 5.0 \text{ Adc, T} \\ \end{array} $	R _{DS(on)}		28 50	34 60	mΩ	
Source–Drain Forward On Voltage $(I_S = 5 \text{ A}, V_{GS} = 0 \text{ V})$		V _{SD}		0.80	1.1	V
SWITCHING CHARACTERISTICS (Note	4)	•		•	•	•
Turn-ON Time (10% V _{IN} to 90% I _D)	V _{IN} = 0 V to 5 V, V _{DD} = 25 V	t _{ON}		41	50	μs
Turn-OFF Time (90% V _{IN} to 10% I _D)	$I_D = 1.0 \text{ A}, \text{ Ext } R_G = 2.5 \Omega$	t _{OFF}		129	150	1
Turn-ON Time (10% V _{IN} to 90% I _D)	V _{IN} = 0 V to 10 V, V _{DD} = 25 V	t _{ON}		16	25	
Turn-OFF Time (90% V _{IN} to 10% I _D)	$I_D = 1.0 \text{ A, Ext R}_G = 2.5 \Omega$	t _{OFF}		164	180	
Slew-Rate ON (80% V _{DS} to 50% V _{DS})	V_{in} = 0 to 10 V, V_{DD} = 12 V, R_L = 4.7 Ω	-dV _{DS} /dt _{ON}		1.27	2.0	V/μs
Slew-Rate OFF (50% V _{DS} to 80% V _{DS})	$R_L = 4.7 \Omega$	dV_{DS}/dt_{OFF}		0.36	0.75	
SELF PROTECTION CHARACTERISTIC	S ($T_J = 25^{\circ}C$ unless otherwise noted)					
Current Limit	V _{GS} = 5.0 V, V _{DS} = 10 V V _{GS} = 5.0 V, T _J = 150°C (Note 4)	I _{LIM}	25 11	30 16	35 21	Adc
	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ $V_{GS} = 10 \text{ V}, T_J = 150^{\circ}\text{C} \text{ (Note 4)}$		30 18	35 25	40 28	
Temperature Limit (Turn-off)	V _{GS} = 5.0 V (Note 4)	$T_{LIM(off)}$	150	175	200	°C
Thermal Hysteresis	$V_{GS} = 5.0 \text{ V}$	$\Delta T_{LIM(on)}$		15		°C
Temperature Limit (Turn-off)	$V_{GS} = 10 \text{ V (Note 4)}$	$T_{LIM(off)}$	150	165	185	°C
Thermal Hysteresis	V _{GS} = 10 V	$\Delta T_{LIM(on)}$		15		°C
GATE INPUT CHARACTERISTICS (Note		1	ı		T	T .
Device ON Gate Input Current	$V_{GS} = 5 V I_D = 1.0 A$	I _{GON}		50	100	μΑ
	$V_{GS} = 10 \text{ V } I_{D} = 1.0 \text{ A}$			400	700	
Current Limit Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	IGCL		0.1	0.5	mA
The model in the transfer of t	V _{GS} = 10 V, V _{DS} = 10 V			0.7	1.0	<u> </u>
Thermal Limit Fault Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GTL}		0.6	1.0	mA
	V _{GS} = 10 V, V _{DS} = 10 V			2.0	4.0	1
ESD ELECTRICAL CHARACTERISTICS	$(T_J = 25^{\circ}C \text{ unless otherwise noted}) (N_J = 25^{\circ}C \text{ unless otherwise noted})$	1	1		i	1
Electro-Static Discharge Capability Human Body Model (HBM) Machine Model (MM)		ESD	4000 400			V

^{4.} Not subject to production testing.
5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

TYPICAL PERFORMANCE CURVES



at 25°C

TYPICAL PERFORMANCE CURVES

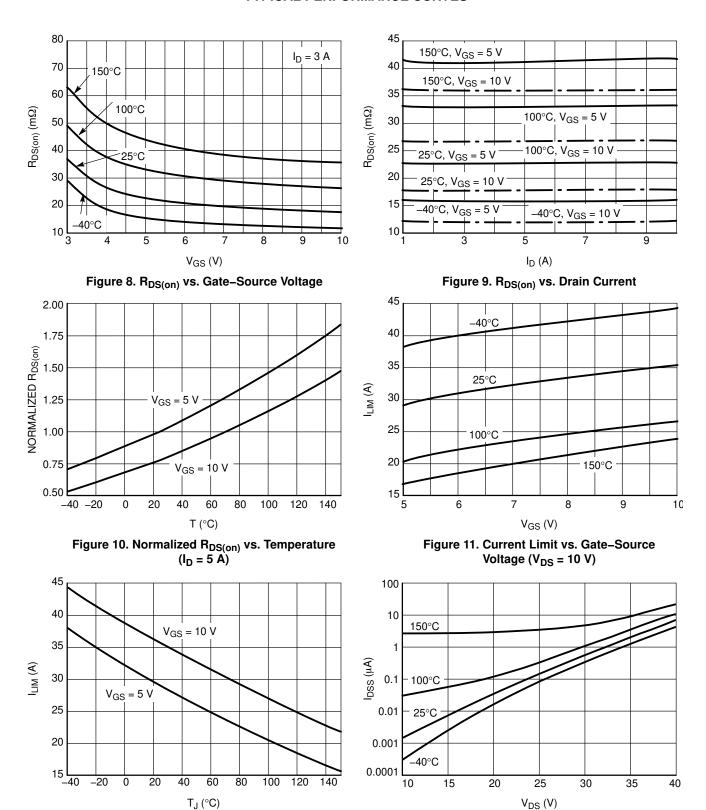
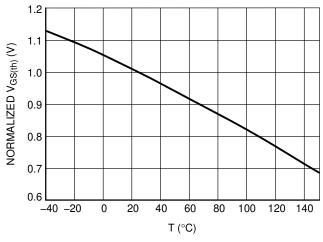


Figure 12. Current Limit vs. Junction Temperature (V_{DS} = 10 V)

Figure 13. Drain-to-Source Leakage Current (V_{GS} = 0 V)

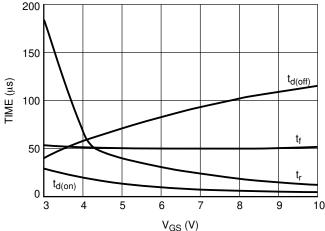
TYPICAL PERFORMANCE CURVES



1.0 0.9 –40°C 8.0 25°C $V_{SD}(V)$ 0.7 100°C 0.6 150°C 0.5 0.4 2 3 4 5 6 8 9 10 $I_S(A)$

Figure 14. Normalized Threshold Voltage vs. Temperature ($I_D = 1.2 \text{ mA}, V_{DS} = V_{GS}$)

Characteristics (V_{GS} = 0 V) 2.0 1.5 1.0



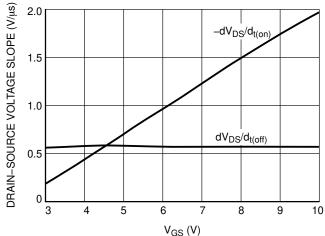
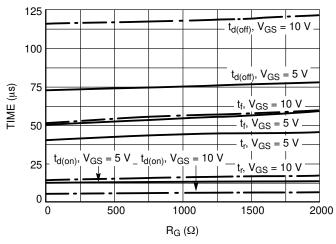


Figure 15. Source-Drain Diode Forward

Figure 16. Resistive Load Switching Time vs. Gate-Source Voltage $(V_{DD} = 25 \text{ V}, I_D = 5 \text{ A}, R_G = 0 \Omega)$

Figure 17. Resistive Load Switching Drain-Source Voltage Slope vs. Gate-Source Voltage ($V_{DD} = 25 \text{ V}$, $I_D = 5 \text{ A}$, $R_G = 0 \Omega$)



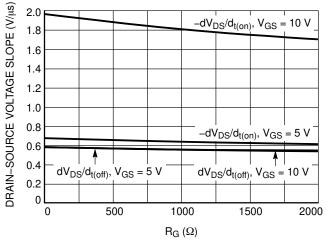


Figure 18. Resistive Load Switching Time vs. Gate Resistance (V_{DD} = 25 V, I_D = 5 A)

Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance $(V_{DD} = 25 \text{ V}, I_D = 5 \text{ A})$

TYPICAL PERFORMANCE CURVES

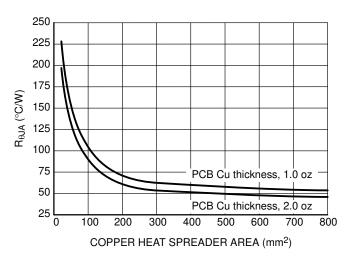


Figure 20. $R_{\theta JA}$ vs. Copper Area

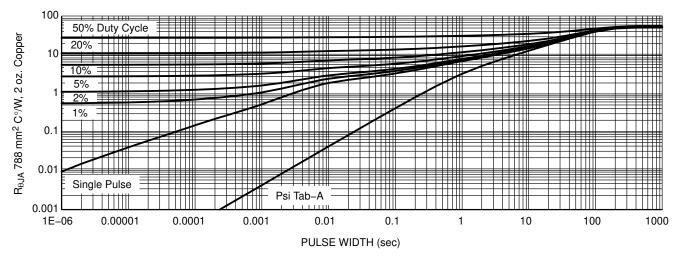


Figure 21. Transient Thermal Resistance

TEST CIRCUITS AND WAVEFORMS

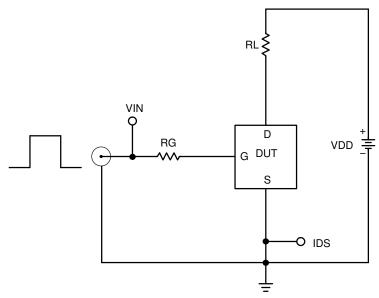


Figure 22. Resistive Load Switching Test Circuit

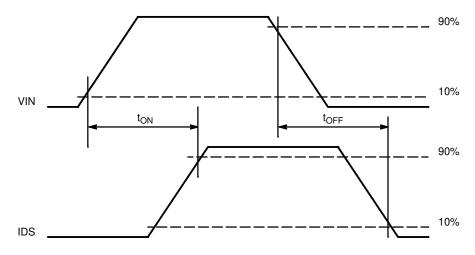


Figure 23. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

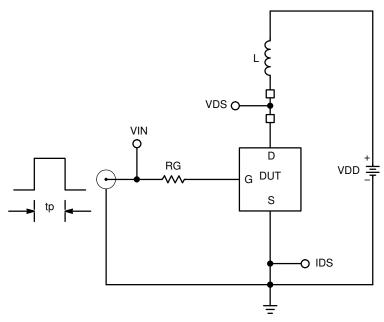


Figure 24. Inductive Load Switching Test Circuit

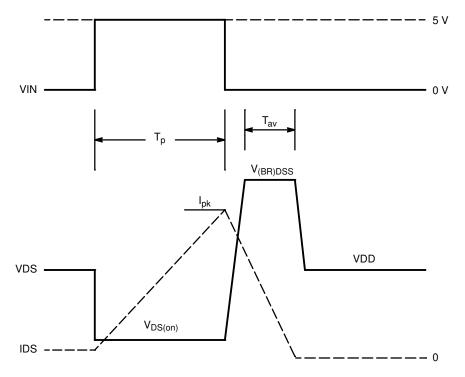
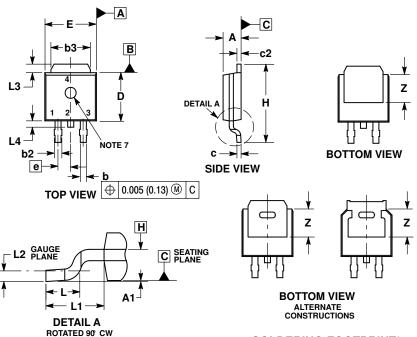


Figure 25. Inductive Load Switching Waveforms

PACKAGE DIMENSIONS

DPAK CASE 369C ISSUE F



NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- MENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PI ANF H
- 7. OPTIONAL MOLD FEATURE.

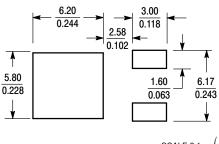
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114 REF		2.90 REF		
L2	0.020 BSC 0.51 BSC		BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

STYLE 2:

- PIN 1. GATE 2. DRAIN

 - 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



mm SCALE 3:1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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